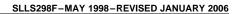
## SN65LVDS94



DGG PACKAGE



# LVDS SERDES RECEIVER

## FEATURES

•	4:28 Data Channel Expansion at up to 1.904 Gigabits per Second Throughput	U	(TOP VI		
•	Suited for Point-to-Point Subsystem	D22 [	1•	56 V	СС
	Communication With Very Low EMI	D23 [	2	55 D	21
•	4 Data Channels and Clock Low-Voltage	D24 [		54 D	
	Differential Channels in and 28 Data and	GND [	4	53 D	
	Clock Out Low-Voltage TTL Channels Out	D25 [	5	52 G	
•	Operates From a Single 3.3-V Supply and	D26 [	6	51 D	
	250 mW (Typ)	D27		50 D	
•	5-V Tolerant SHTDN Input		8	49 D	
•	Rising Clock Edge Triggered Outputs	AOM		48 V	
		AOP	· · ·	47 D	
•	Bus Pins Tolerate 4-kV HBM ESD	A1M	11	46 D	
•	Packaged in Thin Shrink Small-Outline	A1P	12	45 D	
	Package With 20 Mil Terminal Pitch	LVDSV <sub>CC</sub> [	13	44 G	
•	Consumes <1 mW When Disabled	LVDSGND [	14	43 D	
٠	Wide Phase-Lock Input Frequency Range	A2M [ A2P [	15	42 D	
	20 MHz to 68 MHz	A2P [ CLKINM [	16 17	-	
•	No External Components Required for PLL			40 V 39 D	
•	Meets or Exceeds the Requirements of ANSI	A3M [	19	38 D	
	EIA/TIA-644 Standard	A3M [ A3P ]	20	37 D	
•	Industrial Temperature Qualified	LVDSGND		36 G	
	$T_{A} = -40^{\circ}$ C to 85°C	PLLGND [		35 D	
•	Replacement for the DS90CR286	PLLV <sub>CC</sub> [	23	34 D	
•		PLLGND		33 D	
		SHTDN [	25	32 D	
		CLKOUT	26	31 V	
		D0 [	27	30 D	
		GND [	28	29 D	
		-			

## DESCRIPTION

The SN65LVDS94 LVDS serdes (serializer/deserializer) receiver contains four serial-in 7-bit parallel-out shift registers, a 7x clock synthesizer, and five low-voltage differential signaling (LVDS) line receivers in a single integrated circuit. These functions allow receipt of synchronous data from a compatible transmitter, such as the SN65LVDS93 and SN65LVDS95, over five balanced-pair conductors and expansion to 28 bits of single-ended LVTTL synchronous data at a lower transfer rate.

When receiving, the high-speed LVDS data is received and loaded into registers at the rate seven times the LVDS input clock (CLKIN). The data is then unloaded to a 28-bit wide LVTTL parallel bus at the CLKIN rate. A phase-locked loop clock synthesizer circuit generates a 7× clock for internal clocking and an output clock for the expanded data. The SN65LVDS94 presents valid data on the rising edge of the output clock (CLKOUT).



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

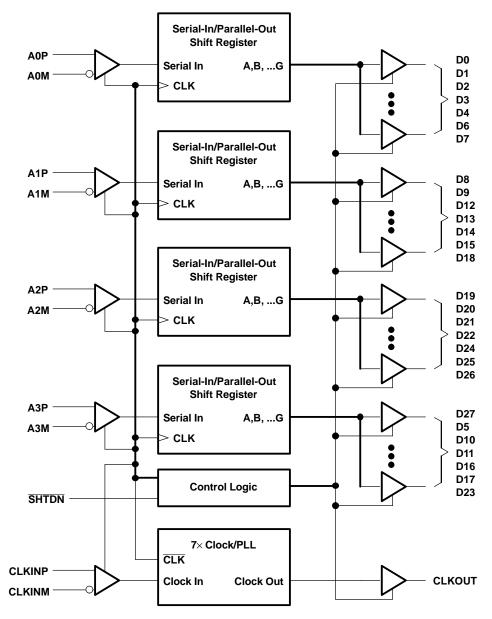


These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## **DESCRIPTION (CONTINUED)**

The SN65LVDS94 requires only five line termination resistors for the differential inputs and little or no control. The data bus appears the same at the input to the transmitter and output of the receiver with the data transmission transparent to the user(s). The only user intervention is the possible use of the shutdown/clear (SHTDN) active-low input to inhibit the clock and shut off the LVDS receivers for lower power consumption. A low level on this signal clears all internal registers to a low level.

The SN65LVDS94 is characterized for operation over ambient air temperatures of -40°C to 85°C.



#### FUNCTIONAL BLOCK DIAGRAM



## SN65LVDS94

SLLS298F-MAY 1998-REVISED JANUARY 2006

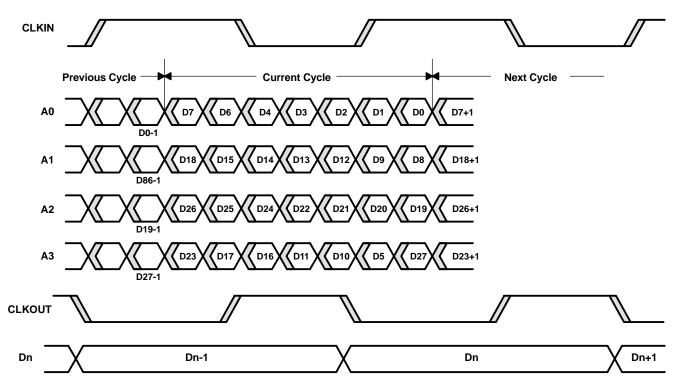
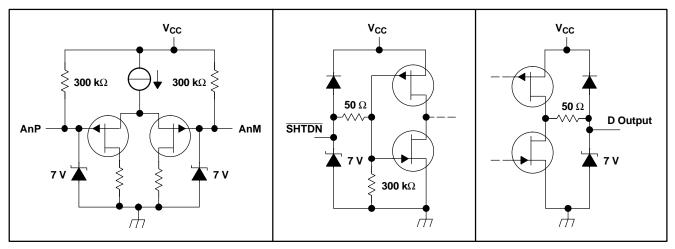


Figure 1. SN65LVDS94 Load and Shift Sequences

#### EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS



#### **ABSOLUTE MAXIMUM RATINGS**

over operating free-air temperature (unless otherwise noted) <sup>(1)</sup>

			UNIT
$V_{CC}^{(2)}$	Supply voltage range		-0.3 V to 4 V
	Voltage range at any terminal (except SHTDN)	-0.5 V to V <sub>CC</sub> + 0.5 V	
	Voltage range at SHTDN terminal		-0.5 V to V <sub>CC</sub> + 3 V
		Bus pins (Class 3A)	4 KV
	Electrostatic discharge (3)	Bus pins (Class 2B)	200 V
	Electrostatic discharge <sup>(3)</sup>	All pins (Class 3A)	3 KV
		All pins (Class 2B)	200 V
	Continuous total power dissipation	(see Dissipation Rating Table)	
T <sub>A</sub>	Operating free-air temperature range		-40°C to 85°C
T <sub>stg</sub>	Storage temperature range	-65°C to 150°C	
	Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C	

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to the GND terminals unless otherwise noted.

(3) This rating is measured using MIL-STD-883C Method, 3015.7.

## **DISSIPATION RATING TABLE**

PACKAGE	T <sub>A</sub> ≤ 25°C	DERATING FACTOR <sup>(1)</sup>	T <sub>A</sub> = 70°C	T <sub>A</sub> = 85°C
	POWER RATING	ABOVE T <sub>A</sub> = 25°C	POWER RATING	POWER RATING
DGG	1377 mW	11 mW/°C	882 mW	717 mW

(1) This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

#### **RECOMMENDED OPERATING CONDITIONS**

		MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage	3	3.3	3.6	
V <sub>IH</sub>	High-level input voltage (SHTDN)	2			
V <sub>IL</sub>	Low-level input voltage (SHTDN)			0.8	
V <sub>ID</sub>	Magnitude of differential input voltage	0.1		0.6	V
V <sub>IC</sub> , see Figure 2 and Figure 3	Common-mode input voltage			$2.4 - \frac{ V_{ID} }{2}$	·
				V <sub>CC</sub> -0.8	
T <sub>A</sub>	Operating free-air temperature	-40		85	°C

#### TIMING REQUIREMENTS

		MIN	NOM	MAX	UNIT
t <sub>c</sub> <sup>(1)</sup>	Input clock period	14.7	t <sub>c</sub>	50	ns

(1)  $t_c$  is defined as the mean duration of a minimum of 32,000 clock periods.

## **ELECTRICAL CHARACTERISTICS**

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IT+</sub>	Positive-going differential input voltage threshold				100	
V <sub>IT-</sub>	Negative-going differential input voltage threshold <sup>(2)</sup>		-100			mV
V <sub>OH</sub>	High-level output voltage	I <sub>OH</sub> = -4 mA	2.4			V
V <sub>OL</sub>	Low-level output voltage	$I_{OL} = 4 \text{ mA}$			0.4	V
I <sub>CC</sub>	Quiescent current (average)	Disabled, all inputs open			280	μA
		Enabled, AnP at 1 V and AnM at 1.4 V, $t_c = 15.38$ ns		62	84	mA
		Enabled, $C_L = 8 \text{ pF}$ (5 places), Worst-case pattern, see Figure 4, $t_c = 15.38 \text{ ns}$		107		mA
I <sub>IH</sub>	High-level input current (SHTDN)	$V_{IH} = V_{CC}$			±20	μA
IIL	Low-level input current (SHTDN)	V <sub>IL</sub> = 0 V			±20	μA
I <sub>IN</sub>	Input current (A and CLKIN inputs)	$0 \text{ V} \leq \text{V}_{\text{I}} \leq 2.4 \text{ V}$			±20	μA
I <sub>OZ</sub>	High-impedance output current	$V_0 = 0 V \text{ or } V_{CC}$			±10	μA

(1)

All typical values are  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C. The algebraic convention, in which the less-positive (more-negative) limit is designated minimum, is used in this data sheet for the (2)negative-going input voltage threshold only.

## SWITCHING CHARACTERISTICS

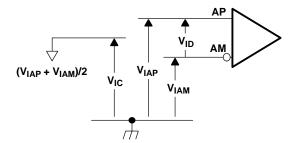
over recommended operating conditions (unless otherwise noted)

PARAN	IETER	TEST CONDITIONS		MIN	TYP <sup>(1)</sup>	MAX	UNIT
t <sub>su</sub>	Data setup time, D0 through D27 to CLKOUT	0.0.5		4	6		
t <sub>h</sub>	Data hold time, CLKOUT to D0 through D27	C <sub>L</sub> = 8 pF	See Figure 5	4	6		ns
t <sub>RSKM</sub>	Receiver input skew margin <sup>(1)</sup> , see Figure 6	t <sub>c</sub> = 15.38 ns (±0.2%),	$T_A = 0^{\circ}C$ to $85^{\circ}C$	490	800		~~~
		Input clock jitter  <50 ps <sup>(2)</sup>	$T_A = -40^{\circ}C$ to $0^{\circ}C$	390			ps
t <sub>d</sub>	Delay time, input clock to output clock, see Figure 6	t <sub>c</sub> = 15.38 ns (±0.2%)			3.7		ns
	Change in output clock period from cycle to	$t_c = 15.38 + 0.75 \text{ sin } (2\pi 500\text{E3}t)\pm 0.05 \text{ ns},$ See Figure 7			±80		
$\Delta t_{C(O)}$	cycle <sup>(3)</sup>	t <sub>c</sub> = 15.38 + 0.75 sin (2≠3E6t) ±0.05 ns, See Figure 7			±300		ps
t <sub>en</sub>	Enable time, SHTDN to phase lock	See Figure 8			1		ms
t <sub>dis</sub>	Disable time, SHTDN to Off state	See Figure 9			400		ns
t <sub>t</sub>	Output transition time (t <sub>r</sub> or t <sub>f</sub> )	C <sub>L</sub> = 8 pF			3		ns
t <sub>w</sub>	Output clock pulse duration				0.43 t <sub>c</sub>		ns

 $t_{RSKM}$  is the timing margin available to allocate to the transmitter and interconnection skews and clock jitter. It is defined by  $\frac{t_c}{14}$ -ts/h. Input clock jitter| is the magnitude of the change in the input clock period.  $\Delta t_{C(O)}$  is the change in the output clock period from one cycle to the next cycle observed over 15,000 cycles. (1)

(2) (3)

## PARAMETER MEASUREMENT INFORMATION





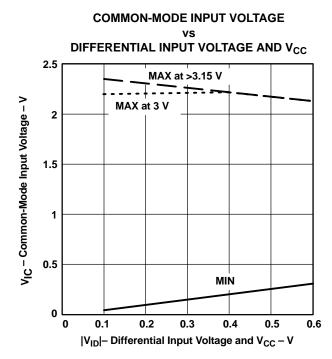
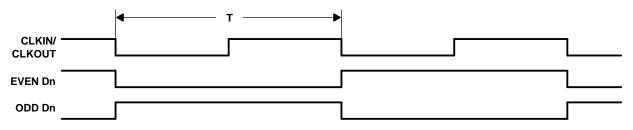


Figure 3. Recommended  $V_{IC}$  Versus  $V_{ID}$  and  $V_{CC}$ 

## PARAMETER MEASUREMENT INFORMATION (continued)





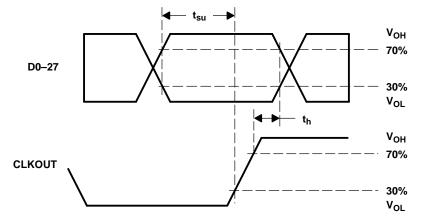
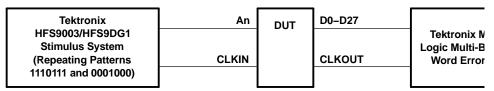


Figure 5. Setup and Hold Time Measurements

## PARAMETER MEASUREMENT INFORMATION (continued)



CLKIN is advanced or delayed with respect to data until errors are observed at the receiver outpu The magnitude of the advance or delay is  $t_{\text{RSKM}}$ .

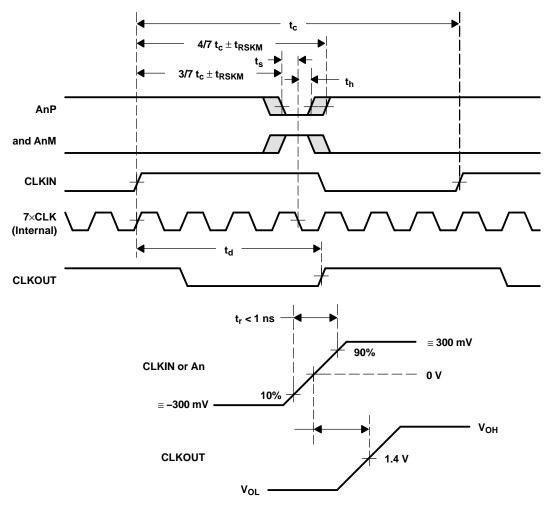
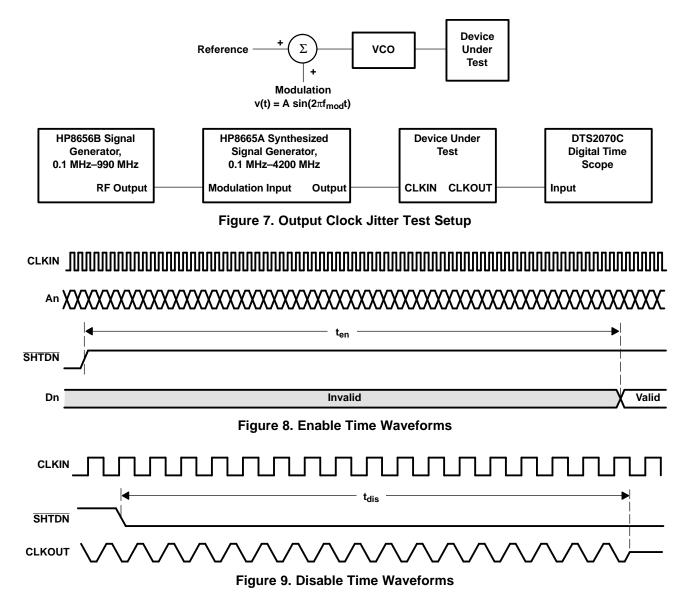
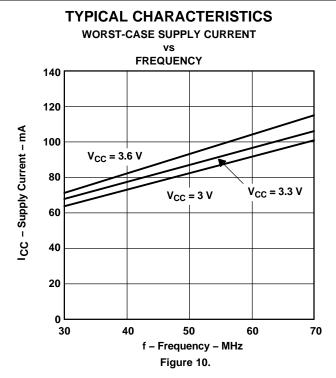


Figure 6. Receiver Input Skew Margin and t<sub>d</sub> Definitions

### PARAMETER MEASUREMENT INFORMATION (continued)







### **APPLICATION INFORMATION**

#### **16-BIT BUS EXTENSION**

In a 16-bit bus application (Figure 11), TTL data and clock coming from bus transceivers that interface the backplane bus arrive at the Tx parallel inputs of the LVDS serdes transmitter. The clock associated with the bus is also connected to the device. The on-chip PLL synchronizes this clock with the parallel data at the input. The data is then multiplexed into three different line drivers which perform the TTL to LVDS conversion. The clock is also converted to LVDS and presented to a separate driver. This synchronized LVDS data and clock at the receiver, which recovers the LVDS data and clock, performs a conversion back to TTL. Data is then demultiplexed into a parallel format. An on-chip PLL synchronizes the received clock with the parallel data, and then all are presented to the parallel output port of the receiver.

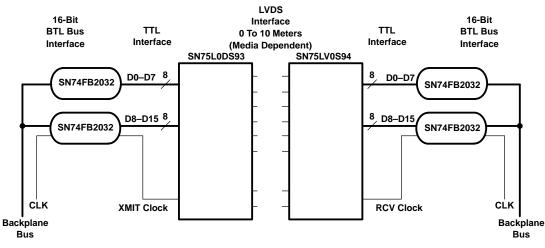


Figure 11. 16-Bit Bus Extension

#### **16-BIT BUS EXTENSION WITH PARITY**

In the previous application we did not have a checking bit that would provide assurance that the data crosses the link. If we add a parity bit to the previous example, we would have a diagram similar to the one in Figure 12. The device following the SN74FB2032 is a low cost parity generator. Each transmit-side transceiver/parity generator takes the LVTTL data from the corresponding transceiver, performs a parity calculation over the byte, and then passes the bits with its calculated parity value on the parallel input of the LVDS serdes transmitter. Again, the on-chip PLL synchronizes this transmit clock with the eighteen parallel bits (16 data + 2 parity) at the input. The synchronized LVDS data/parity and clock arrive at the receiver.

The receiver performs the conversion from LVDS to LVTTL and the transceiver/parity generator performs the parity calculations. These devices compare their corresponding input bytes with the value received on the parity bit. The transceiver/parity generator will assert its parity error output if a mismatch is detected.

#### **APPLICATION INFORMATION (continued)**

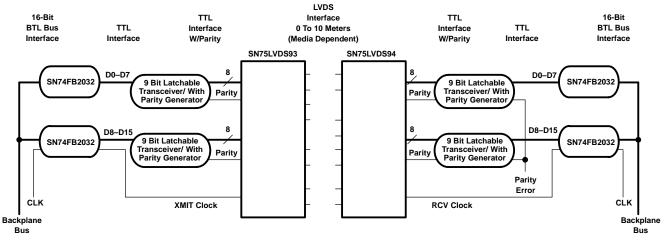


Figure 12. 16-Bit Bus Extension With Parity

#### LOW COST VIRTUAL BACKPLANE TRANSCEIVER

Figure 13 represents LVDS serdes in an application as a virtual backplane transceiver (VBT). The concept of a VBT can be achieved by implementing individual LVDS serdes chipsets in both directions of subsystem serialized links.

Depending on the application, the designer will face varying choices when implementing a VBT. In addition to the devices shown in Figure 13, functions such as parity and delay lines for control signals could be included. Using additional circuitry, half-duplex or full-duplex operation can be achieved by configuring the clock and control lines properly.

The designer may choose to implement an independent clock oscillator at each end of the link and then use a PLL to synchronize LVDS serdes's parallel I/O to the backplane bus. Resynchronizing FIFOs may also be required.

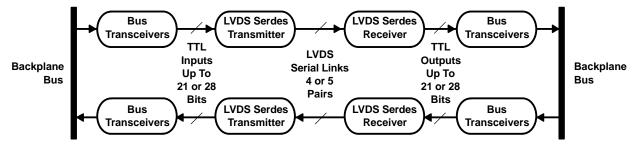


Figure 13. Virtual Backplane Transceiver



11-Apr-2013

## PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing		Qty	(2)		(3)		(4)	
SN65LVDS94DGG	ACTIVE	TSSOP	DGG	56	35	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR		SN65LVDS94	Samples
SN65LVDS94DGGG4	ACTIVE	TSSOP	DGG	56	35	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR		SN65LVDS94	Samples
SN65LVDS94DGGR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	SN65LVDS94	Samples
SN65LVDS94DGGRG4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	SN65LVDS94	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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## PACKAGE OPTION ADDENDUM

11-Apr-2013

# PACKAGE MATERIALS INFORMATION

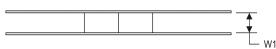
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## TAPE AND REEL INFORMATION

#### REEL DIMENSIONS

TEXAS INSTRUMENTS





#### TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

## TAPE AND REEL INFORMATION

\*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65LVDS94DGGR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

14-Jul-2012



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65LVDS94DGGR	TSSOP	DGG	56	2000	367.0	367.0	45.0

# **PACKAGE OUTLINE**

# **DGG0056A**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not

- exceed 0.15 mm per side. 4. Reference JEDEC registration MO-153.



# DGG0056A

# **EXAMPLE BOARD LAYOUT**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# DGG0056A

# **EXAMPLE STENCIL DESIGN**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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